Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/033,746	CHAN ET AL.	
Examiner	Art Unit	
Isaac M. Woo	2166	

			
SEARCHED			
Class	Subclass	Date	Examiner
. 707	100-104.1	1/11/2007	IW
715	517-530	1/11/2007	IW
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
search - S	SPAT - text See history rintout(s)	1/11/2007	IW

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See search history printout(s), ACM, IEEE, Google	1/11/2007	IW
Consulted with Tod Swan for 101 issue, No 101 problem	1/11/2007	IW
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